

INFORMATION DISCLOSURE CITATION

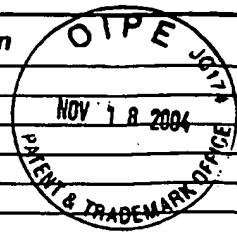
Atty. Docket No. 03180.0355	Application TBA No.
Applicants Hiroshi MATSUSHITA et al.	
Filing Date February 24, 2004	Group: TBA

U.S. PATENT DOCUMENTS						
Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate
m/b	2003-0011376	Jan. 16, 2003	Matsushita et al.	324	500	

FOREIGN PATENT DOCUMENTS						
	Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No
m/b	2002-359266	Dec. 13, 2002	Japan			Abstract

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)	
m/b	Mitsutake, K. et al., "New Method of Extraction of Systematic Failure Component", Proc. 10 th Int. Symp. Semiconductor Manufacturing, pp. 247-250, (2001)
m/b	Sugimoto, M. et al., "Characterization Algorithm of Failure Distribution for LSI Yield Improvement", Proc. 10 th Int. Symp. Semiconductor Manufacturing, pp. 275-278, (2001)
m/b	Nakamae, K. et al., "Fail Pattern Classification and Analysis System of Memory Fail Bit Maps", Proc. 4 th Int. Conf. Modeling and Simulation of Microsystems, pp. 598-601, (2001)
Examiner <i>Michael Z. Brown</i>	Date Considered 7/19/05
*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	
Form PTO 1449 Patent and Trademark Office - U.S. Department of Commerce	

IDS Form PTO/SB/08: Substitute for form 1449A/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Application Number	10/784,819
				Filing Date	February 24, 2004
				First Named Inventor	Hiroshi Matsushita
				Art Unit	2133
				Examiner Name	Unknown
Attorney Docket Number	3180.0355				
Sheet	1	of	1		



U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS					
Examiner Initials	Cite No. ¹	Document Number	Issue or Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
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FOREIGN PATENT DOCUMENTS						
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NON PATENT LITERATURE DOCUMENTS			
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M/b		U.S. Patent Application No. 10/865,927, filed June 14, 2004, to Matsushita et al.	

Examiner Signature		Date Considered	7/19/05
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m/b FEB 17 2005 PATENT & TRADEMARK OFFICE		US-2004-0049722 A1	3/11/04	Matsushita	
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m/b		U.S. Patent Application No. 10/801,992, filed March 17, 2004, to Matsushita et al.	

Examiner Signature	<i>Michael Z. Brown</i>	Date Considered	7/19/05
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